

## Product Summary

$V_{RRM}$	1200 V
$I_F (T_c=150^\circ\text{C})$	20 A
$Q_c$	106 nC

## Features

- Low leakage current ( $I_R$ )
- Zero reverse recovery current
- Temperature independent switching behavior
- Positive temperature coefficient on  $V_F$
- High surge current capacity
- Low capacitive charge

## Benefits

- System cost savings due to smaller magnetics
- System efficiency improvement over Si diodes
- Reduction of heat sink requirements
- Enabling higher frequency
- Reduced EMI

## Applications

- Switch mode power supplies (SMPS)
- Uninterruptible power supplies
- Server/telecom power supplies
- Power factor correction
- Solar

## Package Pin Definitions

- Pin1 and backside - Cathode
- Pin2 - Anode

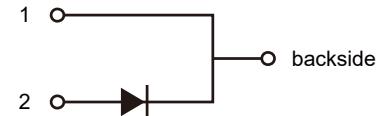
## Package Parameters

Part Number	Marking	Package
B3D20120H	B3D20120H	TO-247-2

## Package: TO-247-2



## Electrical Connection



**Maximum Ratings ( $T_c=25^\circ\text{C}$  unless otherwise specified)**

Symbol	Parameter	Test conditions	Value	Unit
$V_{RRM}$	Repetitive peak reverse voltage		1200	V
$V_{RSM}$	Non-repetitive peak reverse voltage		1200	V
$E_{AS}$	Single pulse avalanche energy	$T_c=25^\circ\text{C}$ , $L=1\text{mH}$ , $I_{AS}=22\text{A}$ , $V=140\text{V}$	242	mJ
$I_F$	Continuous forward current	$T_c=25^\circ\text{C}$	60	A
		$T_c=135^\circ\text{C}$	28	
		$T_c=150^\circ\text{C}$	20	
$I_{FSM}$	Non-repetitive forward surge current	$T_c=25^\circ\text{C}$ , $t_p=10\text{ms}$ Half sine wave	160	A
$I_{FRM}$	Repetitive forward surge current	$T_c=25^\circ\text{C}$ , $t_p=10\text{ms}$ Half sine wave	90	A
$\int i^2 dt$	$i^2 t$ value	$T_c=25^\circ\text{C}$ , $t_p=10\text{ms}$	128	$\text{A}^2\text{s}$
$P_{tot}$	Power dissipation	$T_c=25^\circ\text{C}$ $T_c=110^\circ\text{C}$	259 112	W
$T_j$	Operating junction temperature		-55~175	$^\circ\text{C}$
$T_{stg}$	Storage temperature		-55~175	$^\circ\text{C}$
	TO-247 mounting torque	M3 Screw	0.7	Nm

**Thermal Characteristics**

Symbol	Parameter	Value			Unit
		Min.	Typ.	Max.	
$R_{th(jc)}$	Thermal resistance from junction to case		0.58		K/W

**Electrical Characteristics**
**Static Characteristics**

Symbol	Parameter	Test conditions	Value			Unit
			Min.	Typ.	Max.	
$V_{DC}$	DC blocking voltage	$T_j=25^\circ\text{C}$	1200			V
$V_F$	Diode forward voltage	$I_F=20\text{A} T_j=25^\circ\text{C}$ $I_F=20\text{A} T_j=175^\circ\text{C}$		1.40 2.03	1.62 2.52	V
$I_R$	Reverse current	$V_R=1200\text{V} T_j=25^\circ\text{C}$ $V_R=1200\text{V} T_j=175^\circ\text{C}$		5 20	80 150	$\mu\text{A}$

**AC Characteristics**

Symbol	Parameter	Test conditions	Value			Unit
			Min.	Typ.	Max.	
$Q_C$	Total capacitive charge	$V_R=800\text{V} T_j=25^\circ\text{C}$ $Q_C=\int_0^{V_R} C(V)dV$		106		nC
C	Total capacitance	$V_R=1\text{V} f=1\text{MHz}$ $V_R=400\text{V} f=1\text{MHz}$ $V_R=800\text{V} f=1\text{MHz}$		1180 100 73		pF
$E_C$	Capacitance stored energy	$V_R=800\text{V}$		55		$\mu\text{J}$

### Typical Performance

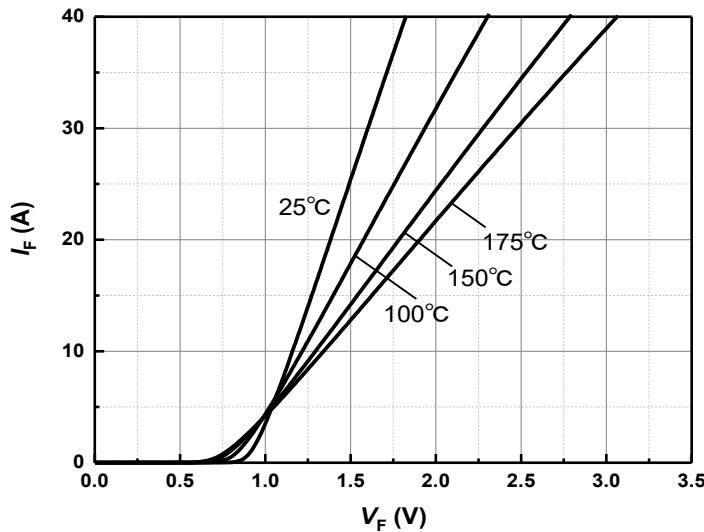


Figure 1 Typical forward characteristics

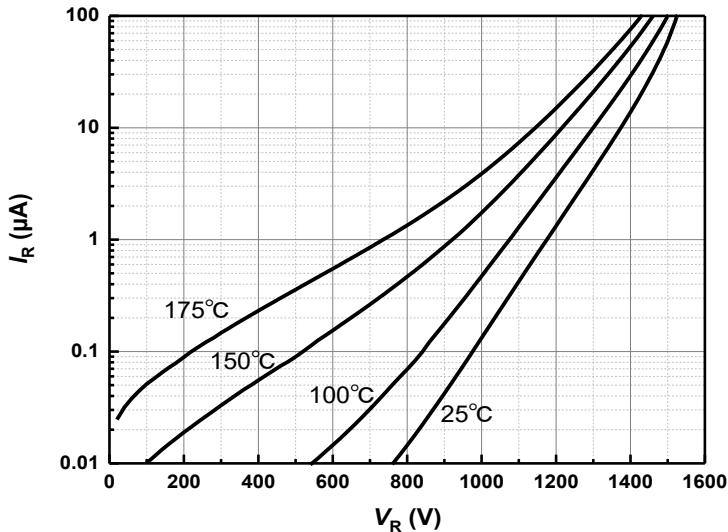


Figure 2 Typical reverse current as function of reverse voltage

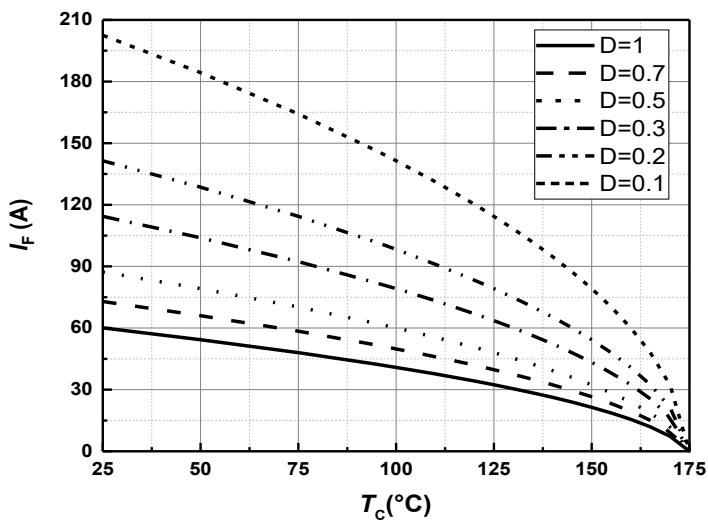


Figure 3 Diode forward current as function of temperature, D=duty cycle

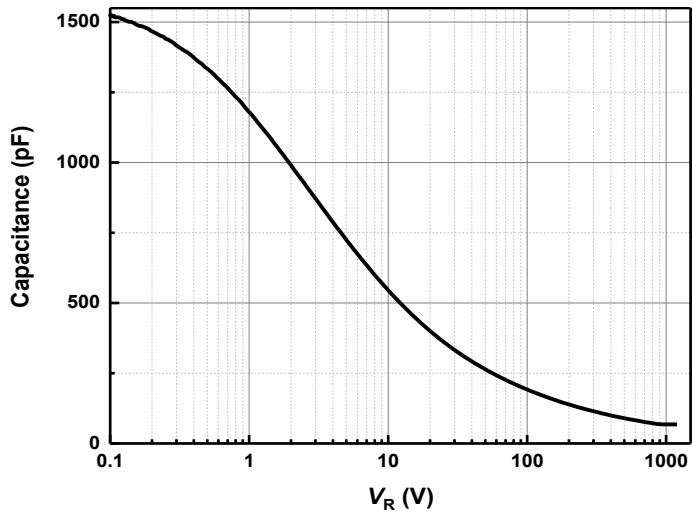
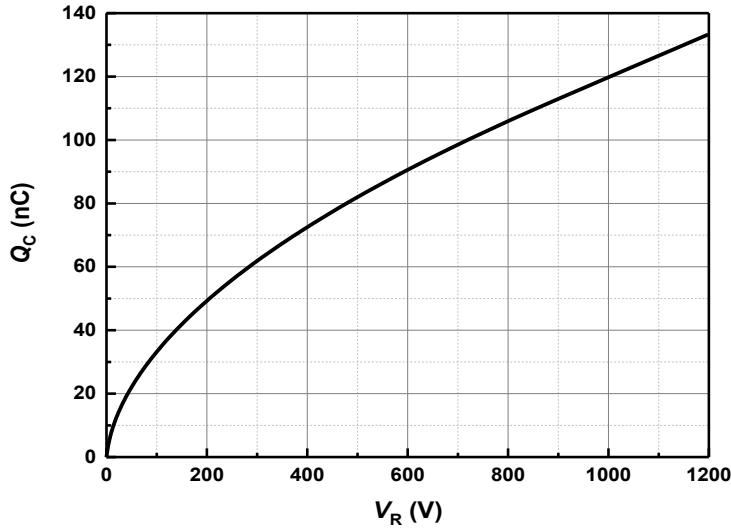
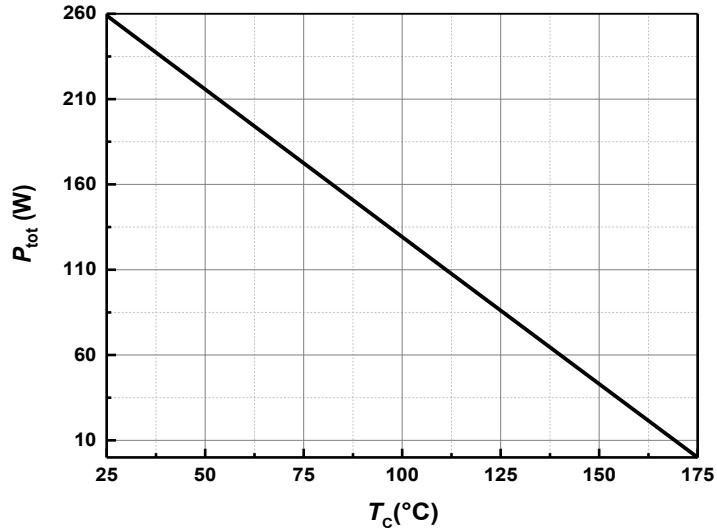


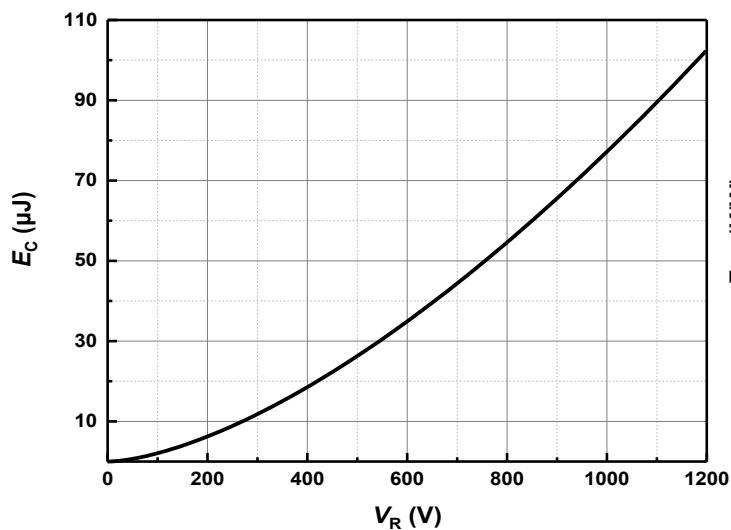
Figure 4 Typical capacitance as function of reverse voltage,  $C=f(V_R)$ ;  $T_j=25^\circ\text{C}$ ;  $f=1 \text{ MHz}$

**Typical Performance**


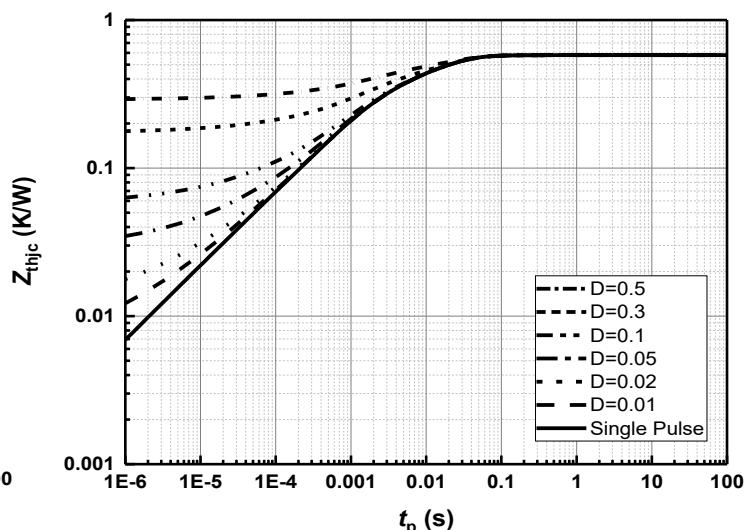
**Figure 5**    **Typical reverse charge as function of reverse voltage**



**Figure 6**    **Power dissipation as function of case temperature**

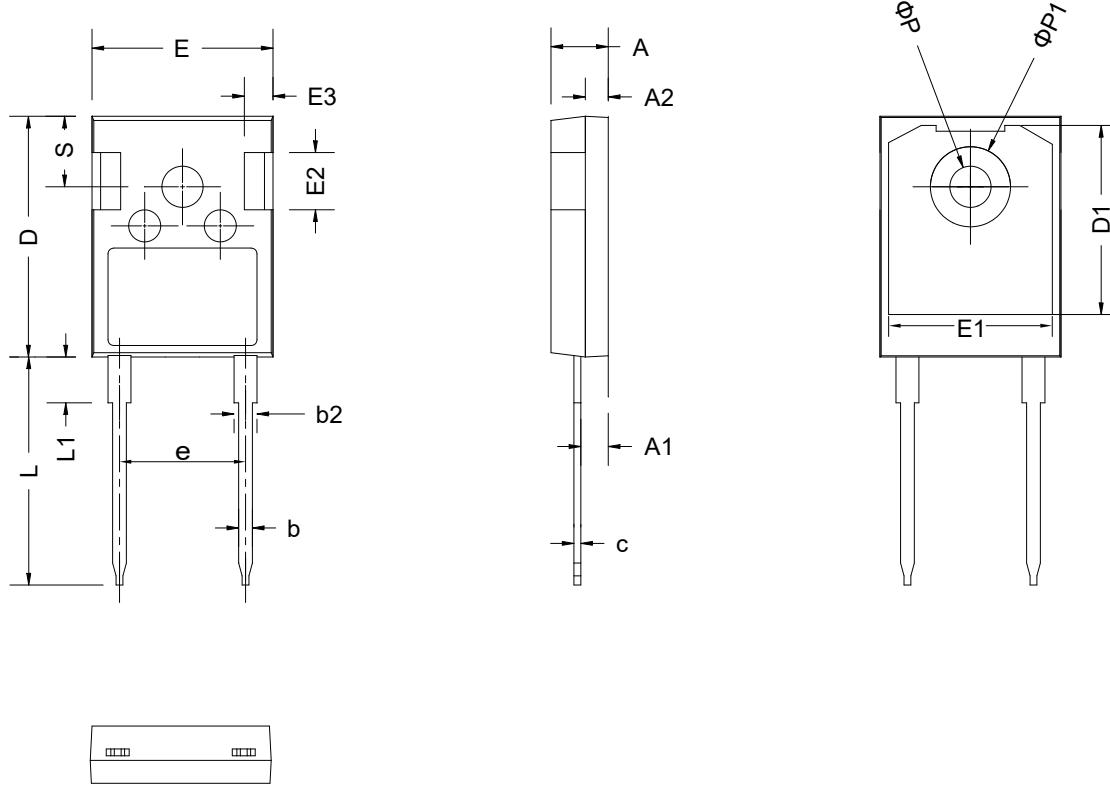


**Figure 7**    **Capacitance stored energy**

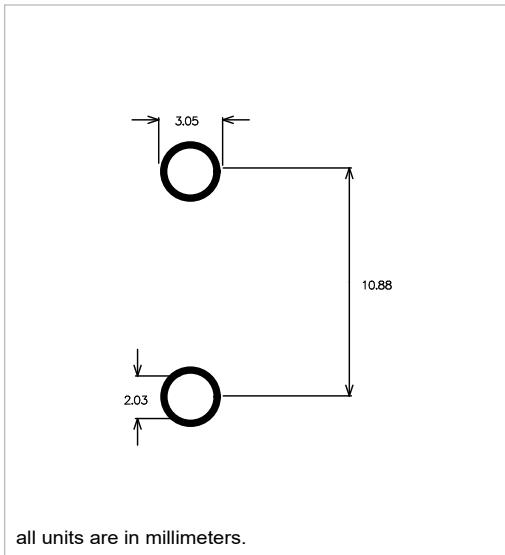


**Figure 8**    **Max. transient thermal impedance,  $Z_{thjc} = f(t_p)$ , parameter:  $D = t_p / T$**

### Package Dimensions



### Recommended Solder Pad Layout



SYMBOL	mm		
	MIN	NOM	MAX
A	4.80	5.00	5.20
A1	2.21	2.41	2.61
A2	1.85	2.00	2.15
b	1.11	1.21	1.36
b2	1.91	2.01	2.21
c	0.51	0.61	0.75
D	20.70	21.00	21.30
D1	16.25	16.55	16.85
E	15.50	15.80	16.10
E1	13.00	13.30	13.60
E2	4.40	-	5.20
E3	1.50	-	2.70
e	10.88 BSC		
L	19.62	19.92	20.22
L1	-	-	4.30
φ P	3.40	3.60	3.80
φ P1	-	-	7.40
S	6.15 BSC		

## Revision History

Document Version	Date of Release	Description of Changes
Rev. 0.0	2023-07-04	Release of the datasheet.

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**Shenzhen, China**  
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